FQPF12N60



SEMICONDUCTOR

# **FQPF12N60** 600V N-Channel MOSFET

### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

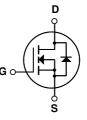
### **Features**

+ 5.8A, 600V,  ${\rm R}_{\rm DS(on)}$  = 0.7  $\Omega$  @ V\_{GS} = 10 V + Low gate charge ( typical 42 nC)

April 2000

FET™

- Low Crss (typical 25 pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- GDS **TO-220F** FQPF Series



## Absolute Maximum Ratings $T_{c} = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQPF12N60	Units
V <sub>DSS</sub>	Drain-Source Voltage		600	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C	)	5.8	Α
	- Continuous (T <sub>C</sub> = 100°	°C)	3.7	A
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	23	A
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	790	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	5.8	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
PD	Power Dissipation ( $T_C = 25^{\circ}C$ )		55	W
	- Derate above 25°C		0.44	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
Τ <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

## **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.27	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$	600			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		0.71		V/°C
I <sub>DSS</sub>	$V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$			10	μA
	Zero Gate Voltage Drain Current	$V_{DS} = 480 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			100	μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS}$ = -30 V, $V_{DS}$ = 0 V			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 2.9 \text{ A}$		0.55	0.7	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_D = 2.9 \text{ A}$ (Note 4)		6.0		S
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		1480	1900	pF
C <sub>oss</sub> C <sub>rss</sub>	Output Capacitance Reverse Transfer Capacitance	f = 1.0 MHz		200 25	270 35	PF PG
Orss	neverse mansier Capacitance			25	35	μ
Switch	ing Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 300 V, I <sub>D</sub> = 12 A,		30	70	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25 \Omega$		115	240	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	u -		95	200	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)		85	180	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 480 V, I <sub>D</sub> = 12 A,		42	54	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		8.6		nC
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4, 5)		21		nC
Durin C						
Drain-S	Source Diode Characteristics ar Maximum Continuous Drain-Source Dic			5.8	А	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				23	A
		$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 5.8 \text{ A}$			1.4	V
Ved	Drain-Source Diode Forward Voltage	$V_{12} = 0$ V, $12 = 3.0$ A				
V <sub>SD</sub>	Drain-Source Diode Forward Voltage Reverse Recovery Time	$V_{GS} = 0 V, I_S = 3.0 A$ $V_{GS} = 0 V, I_S = 12 A,$		380		ns

Q<sub>rr</sub>

Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 43mH,  $I_{AS}$  = 5.8A,  $V_{DD}$  = 50V,  $R_G$  = 25  $\Omega$ , Starting  $T_J$  = 25°C 3.  $I_{SD} \leq 12A$ , di/dt  $\leq 200A/\mu s$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J$  = 25°C 4. Pulse Test : Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ 5. Essentially independent of operating temperature

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FQPF12N60



## **Typical Characteristics**

1.8 1.6

3000

2400

Capacitance [pH]

600

0 L

10

5

15

10

V<sub>DS'</sub> Drain-Source Voltage [V]

Figure 5. Capacitance Characteristics

 $I_{_D}$ , Drain Current [A]

Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

20

25

30

+ C<sub>ad</sub> (C<sub>ds</sub> + C\_d

> 1. V<sub>GS</sub> = 0 V 2. f = 1 MHz

10

35

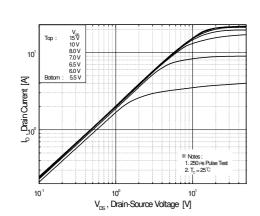


Figure 1. On-Region Characteristics

10V

= 20\

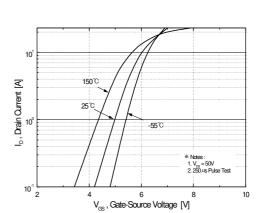
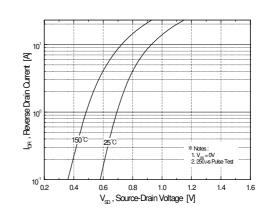
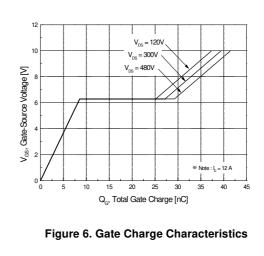


Figure 2. Transfer Characteristics

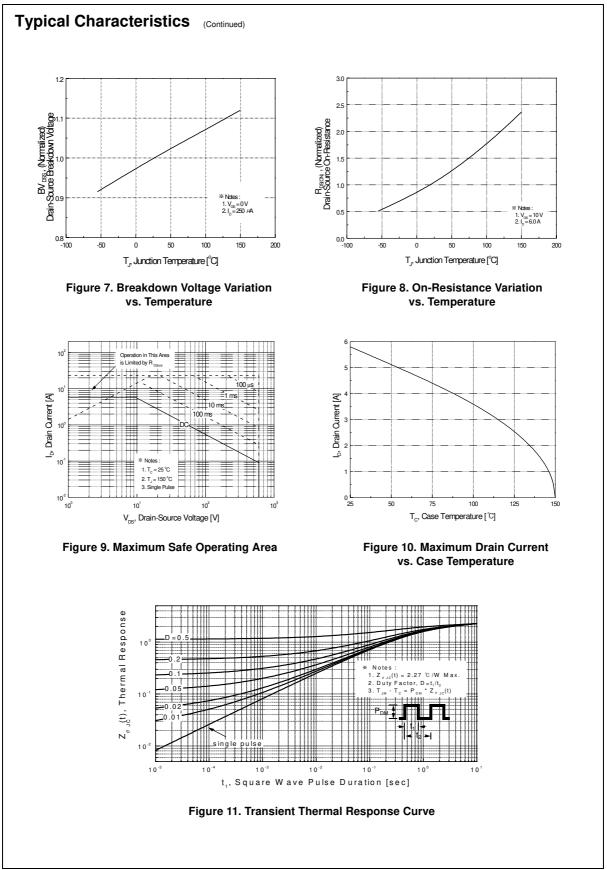




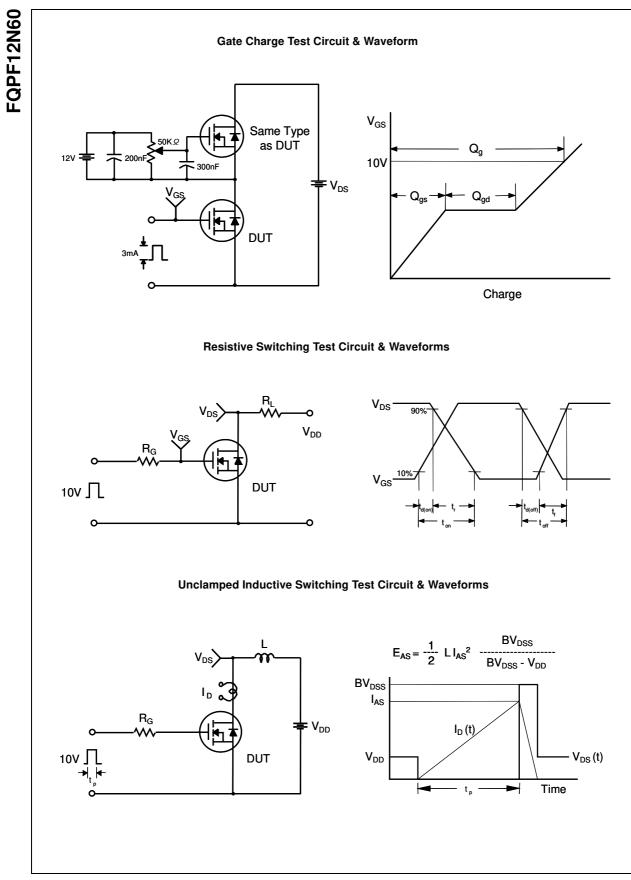




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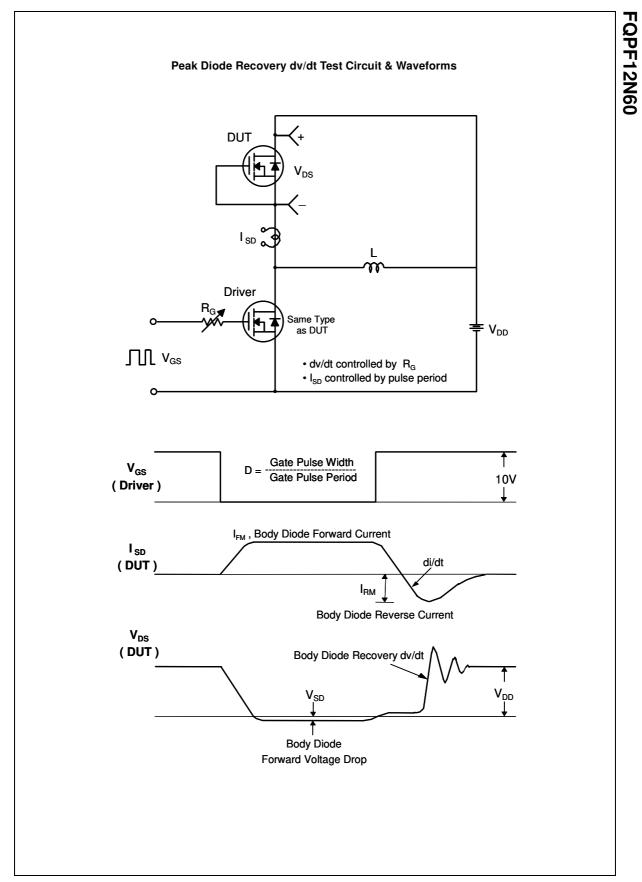


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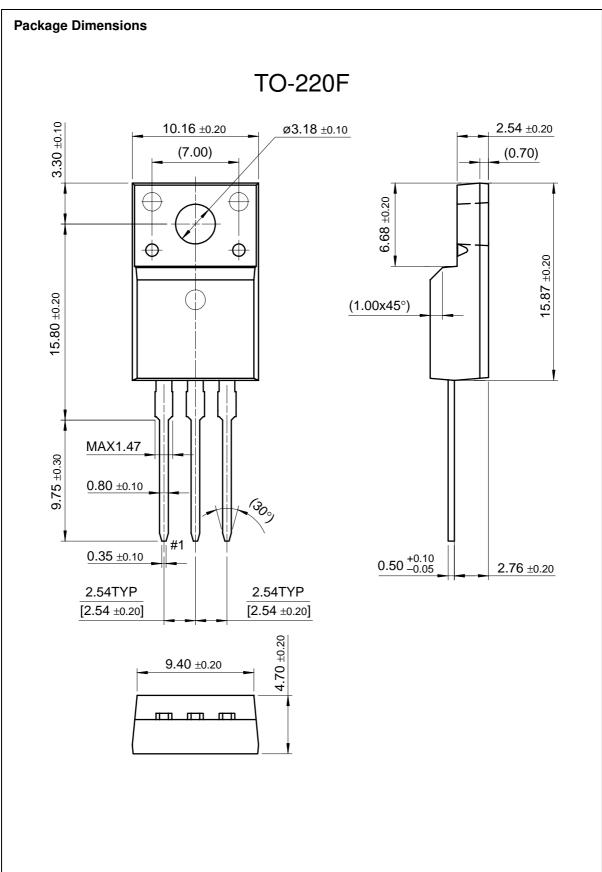
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Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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find products         Products groups         Analog and Mixed         Signal         Discrete         Interface         Logic         Microcontrollers         Non-Volatile         Memory         Optoelectronics         Markets and         applications         New products         Product selection and         parametric search         Cross-reference         search	Home >> Find products >> FQPF12N60 600V N-Channel QFET Contents General description   Features   Product. status/pricing/packaging   Models General description These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.	Datasheet Download this datasheet PDF e-mail this datasheet [E- This pagePrint version	Leolders and Annlica Related Links Request samples Dotted Line How to order products Dotted Line Product Change Notices (PCNs) Dotted Line Support Dotted Line Distributor and field sales representatives Dotted Line Quality and reliability Dotted Line Design tools
my Fairchild company	Features		

- 5.8A, 600V,  $R_{DS(on)} = 0.7\Omega @V_{GS} = 10$ V
- Low gate charge (typical 42 nC)
- Low Crss (typical 25 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

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Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
FQPF12N60	Full Production	\$1.86	<u>TO-220F</u>	3	RAIL
FQPF12N60T	Full Production	\$1.86	<u>TO-220F</u>	3	RAIL

Product Folder - Fairchild P/N FQPF12N60 - 600V N-Channel QFET

\* 1,000 piece Budgetary Pricing

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Models

Package & leads	Condition	Temperature range	Software version	Revision date	
PSPICE					
TO-220F-3	Electrical/Thermal	-55°C to 150°C	9.2	Apr 24, 2001	

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